DASY - Parameters of Probe: ET3DV6 SN:1687

Sensitivity in Free Space

NormX	**1.87** $\mu V/(V/m)^2$
NormY	**1.84** $\mu V/(V/m)^2$
NormZ	**1.64** $\mu V/(V/m)^2$

Diode Compression[A]

DCP X	**95**	mV
DCP Y	**95**	mV
DCP Z	**95**	mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Plese see Page 7.

Boundary Effect

Head **900 MHz** **Typical SAR gradient: 5 % per mm**

Sensor Center to Phantom Surface Distance		**3.7 mm**	**4.7 mm**
SAR_{be} [%]	Without Correction Algorithm	10.4	6.1
SAR_{be} [%]	With Correction Algorithm	0.3	0.5

Head **1800 MHz** **Typical SAR gradient: 10 % per mm**

Sensor Center to Phantom Surface Distance		**3.7 mm**	**4.7 mm**
SAR_{be} [%]	Without Correction Algorithm	13.0	8.9
SAR_{be} [%]	With Correction Algorithm	0.2	0.1

Sensor Offset

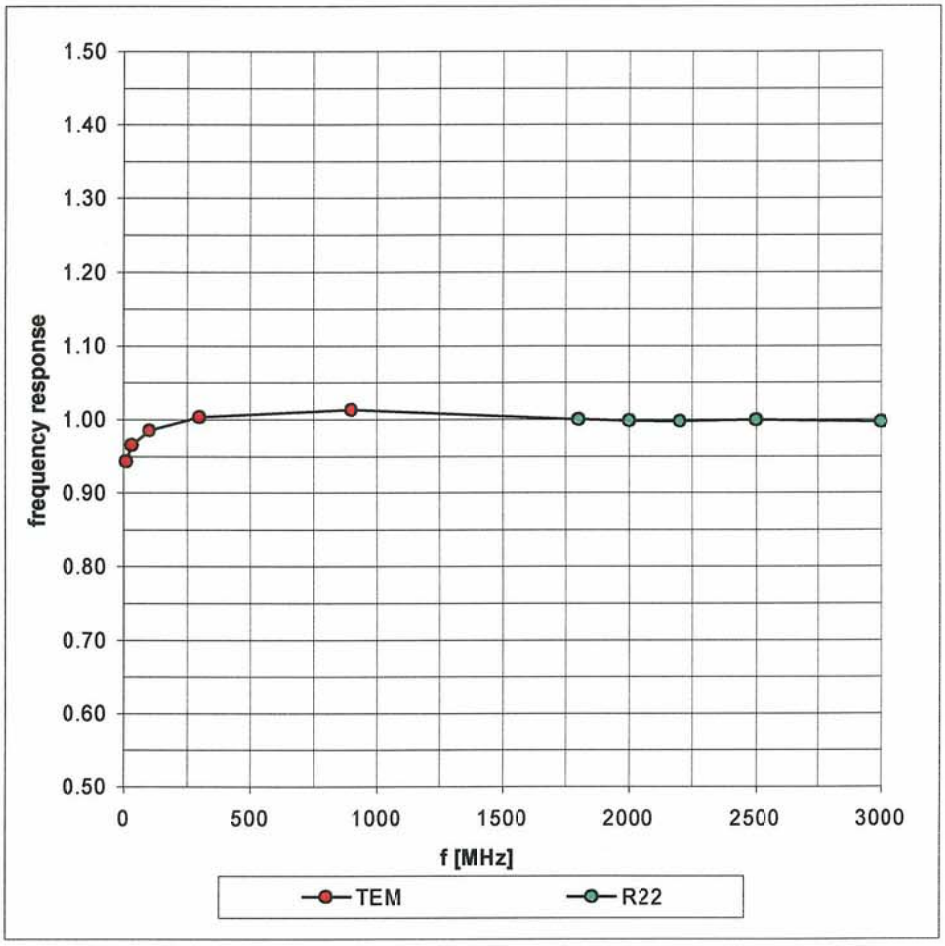
Probe Tip to Sensor Center	**2.7** mm
Optical Surface Detection	**in tolerance**

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

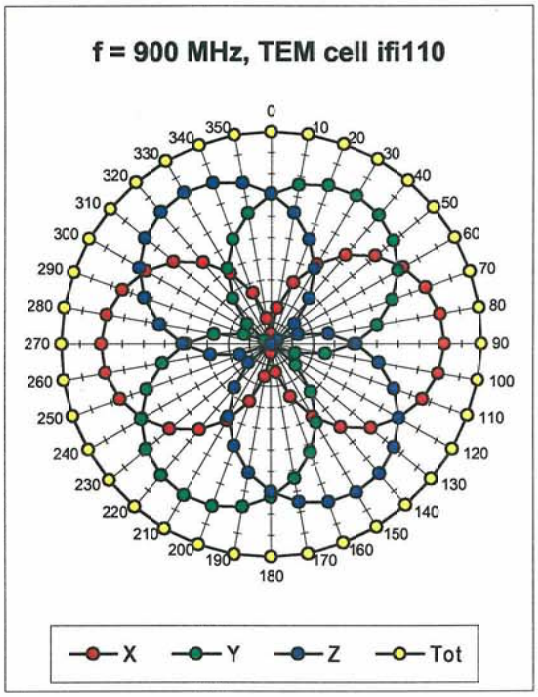
[A] numerical linearization parameter: uncertainty not required

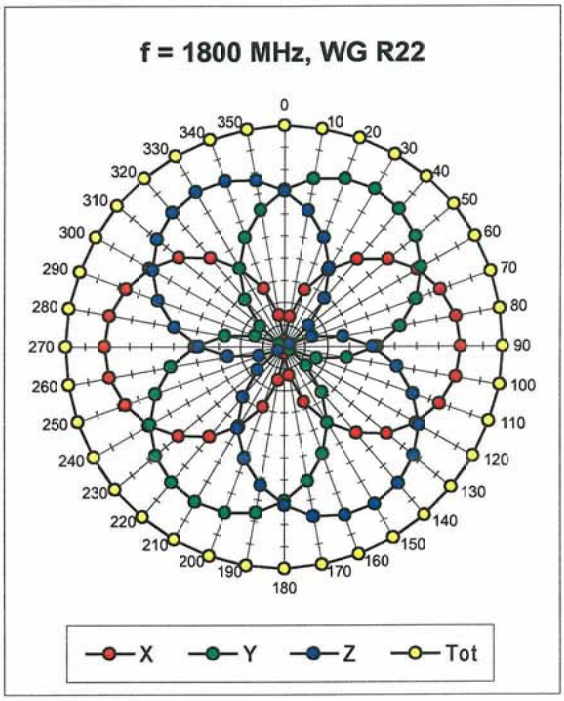
Frequency Response of E-Field

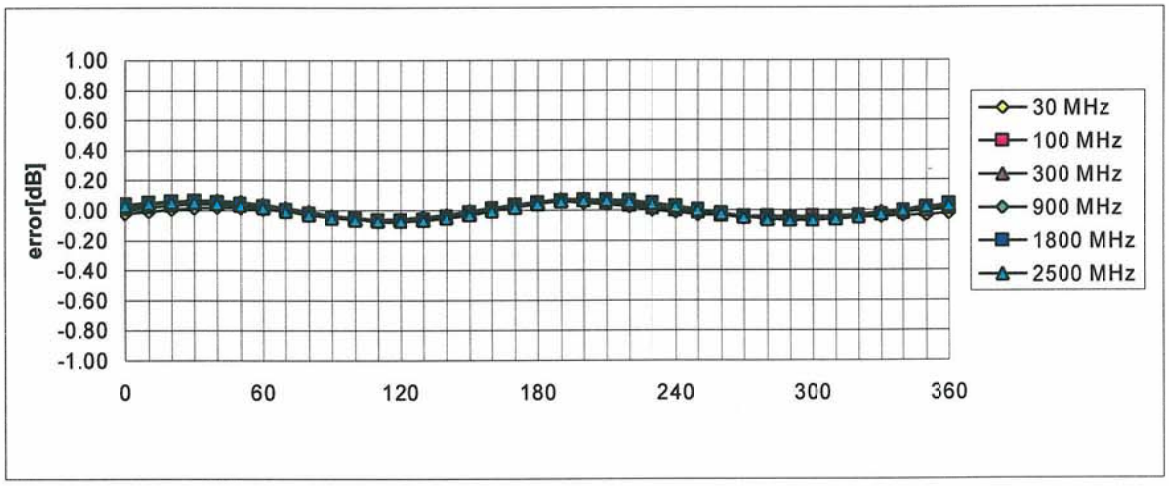
(TEM-Cell:ifi110, Waveguide R22)



Receiving Pattern (ϕ), θ = 0°



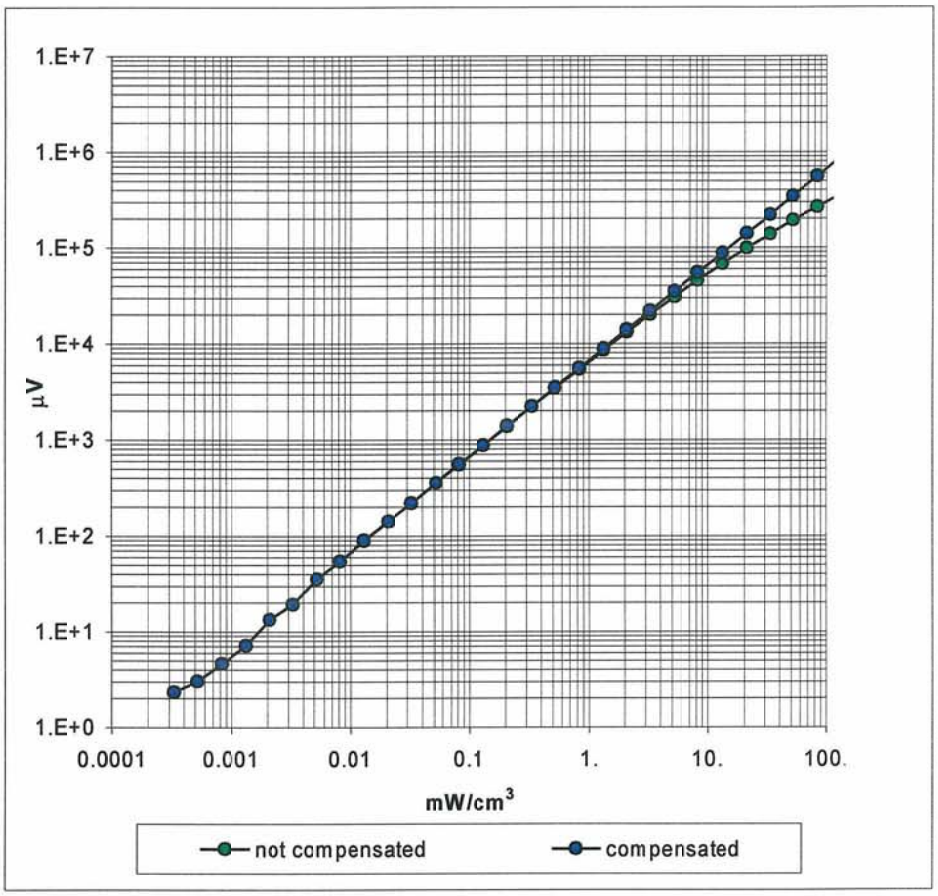


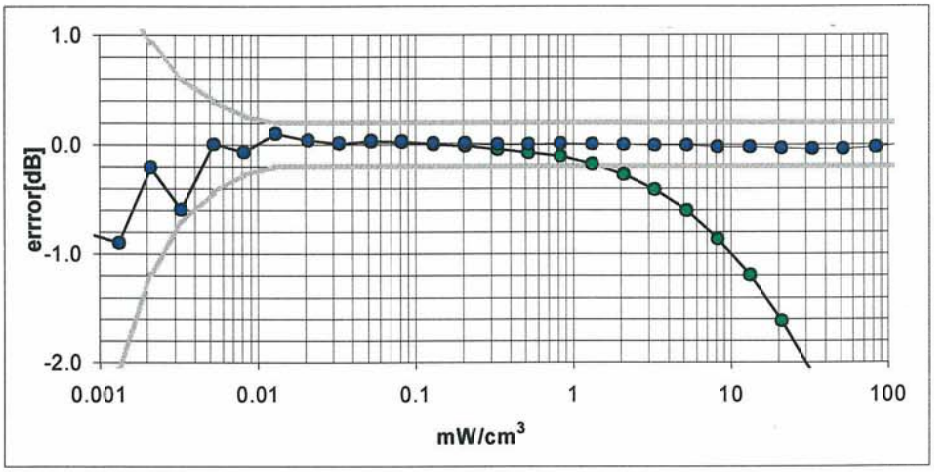


Axial Isotropy Error < ± 0.2 dB

Dynamic Range f(SAR_{head})

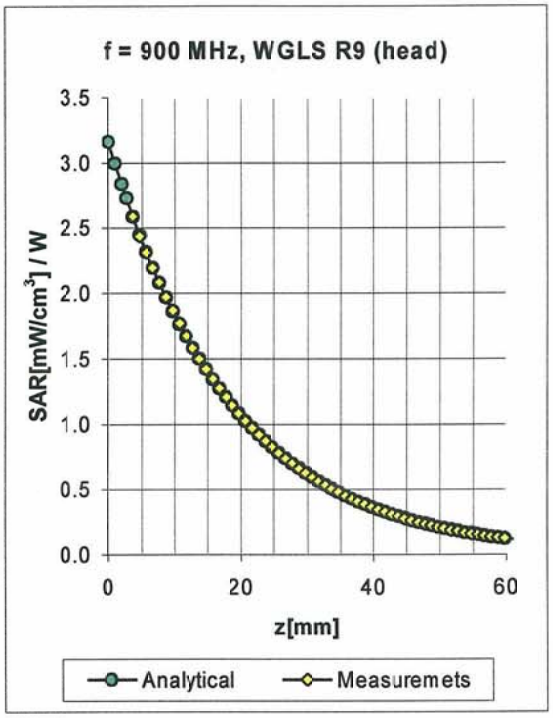
(Waveguide R22)

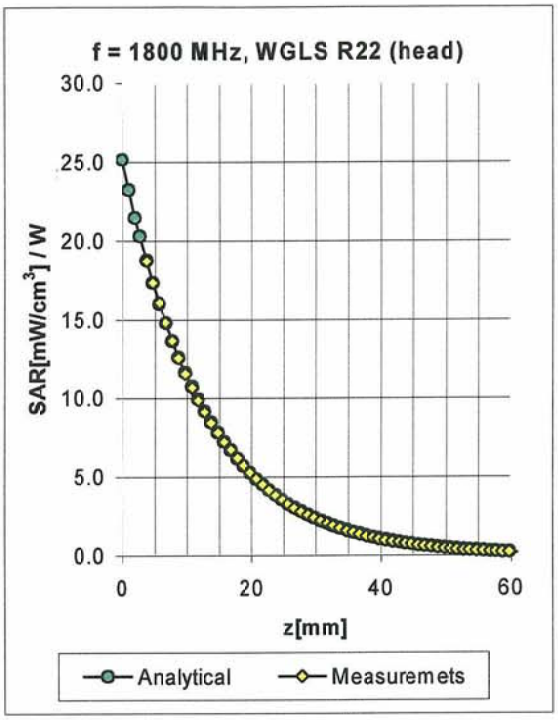




Probe Linearity Error < ± 0.2 dB

Conversion Factor Assessment



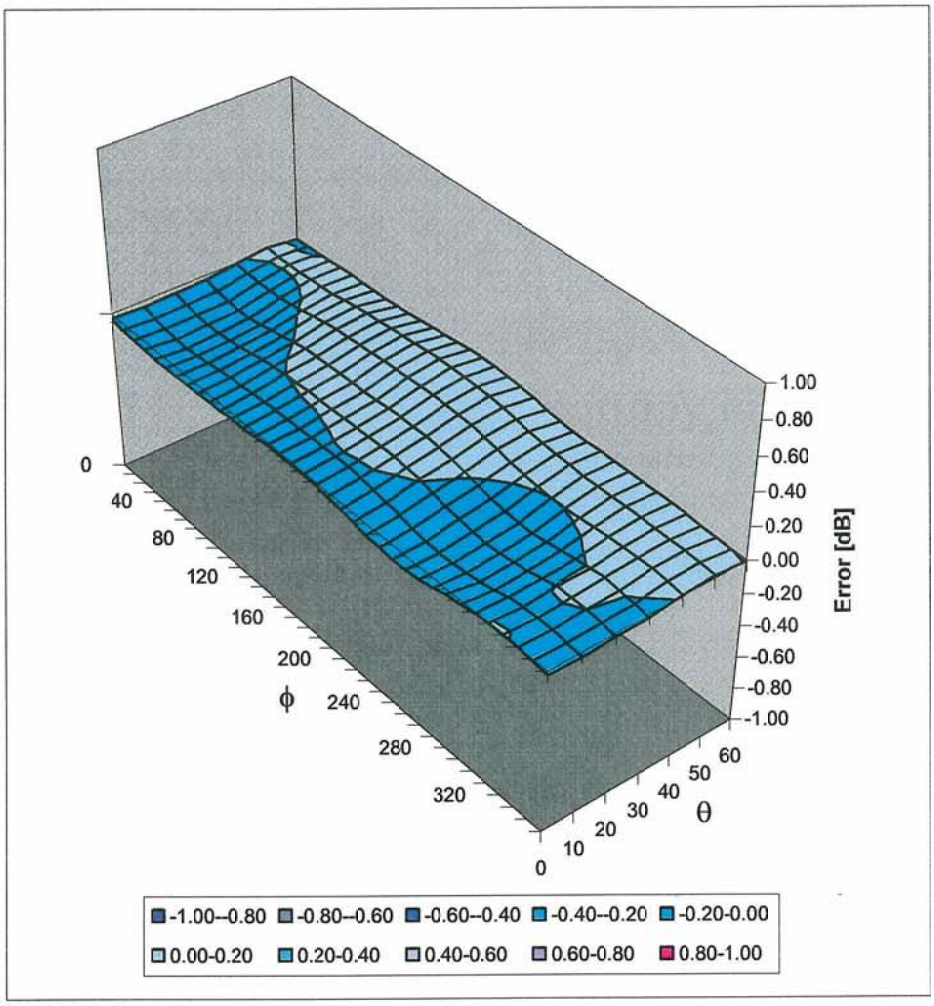


f [MHz]	Validity [MHz][B]	Tissue	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
900	800-1000	Head	41.5 ± 5%	0.97 ± 5%	0.38	2.58	6.34 ± 11.3% (k=2)
1800	1710-1910	Head	40.0 ± 5%	1.40 ± 5%	0.46	2.71	5.16 ± 11.7% (k=2)
2450	2400-2500	Head	39.2 ± 5%	1.80 ± 5%	0.90	1.93	4.41 ± 9.7% (k=2)
900	800-1000	Body	55.0 ± 5%	1.05 ± 5%	0.52	2.10	6.06 ± 11.3% (k=2)
1800	1710-1910	Body	53.3 ± 5%	1.52 ± 5%	0.52	2.88	4.54 ± 11.7% (k=2)
2450	2400-2500	Body	52.7 ± 5%	1.95 ± 5%	1.04	1.62	4.23 ± 9.7% (k=2)

[B] The total standard uncertainty is calculated as root-sum-square of standard uncertainty of the Conversion Factor at calibration frequency and the standard uncertainty for the indicated frequency band.

Deviation from Isotropy in HSL

Error (θ, φ), f = 900 MHz



Spherical Isotropy Error < ± 0.4 dB

D4: DAE

Schmid & Partner Engineering AG

s p e a g

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info@speag.com, http://www.speag.com

IMPORTANT NOTICE

USAGE OF THE DAE 3

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention shall be given to the following points:

Battery Exchange: The battery cover of the DAE3 unit is connected to a fragile 3-pin battery connector. Customer is responsible to apply outmost caution not to bend or damage the connector when changing batteries.

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration Customer shall remove the batteries and pack the DAE in an antistatic bag. The packaging shall protect the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, Customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the annual calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

Important Note:
Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:
Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the E-stop assembly is allowed by certified SPEAG personnel only and is part of the annual calibration procedure.

Schmid & Partner Engineering

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland

Client **Auden ADT**

CALIBRATION CERTIFICATE

Object(s)	DAE3 - SD 000 D03 AA - SN: 510
Calibration procedure(s)	QA CAL-06.v7 Calibration procedure for the data acquisition unit (DAE)
Calibration date:	17.08.2004
Condition of the calibrated item	In Tolerance (according to the specific calibration document)

This calibration statement documents traceability of M&TE used in the calibration procedures and conformity of the procedures with the ISO/IEC 17025 international standard.

All calibrations have been conducted in the closed laboratory facility: environment temperature 22 +/- 2 degrees Celsius and humidity < 75%.

Calibration Equipment used (M&TE critical for calibration)

Model Type	ID #	Cal Date	Scheduled Calibration
Fluke Process Calibrator Type 702	SN: 6295803	8-Sep-03	Sep-04

	Name	Function	Signature
Calibrated by:	Philipp Storchenegger	Technician	
Approved by:	Fin Bomholt	R&D Director	i.V.

Date issued: 17.08.2004

This calibration certificate is issued as an intermediate solution until the accreditation process (based on ISO/IEC 17025 International Standard) for Calibration Laboratory of Schmid & Partner Engineering AG is completed.

1. DC Voltage Measurement

A/D - Converter Resolution nominal

High Range:	1LSB =	6.1μV ,	full range =	-100...+300 mV
Low Range:	1LSB =	61nV ,	full range =	-1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	403.405	403.470	403.844
Low Range	3.95588	3.93301	3.95923
Connector Angle to be used	in DASY System	43 °	

High Range		Input (μV)	Reading (μV)	Error (%)
Channel X	+ Input	200000	199999.5	0.00
Channel X	+ Input	20000	20004.1	0.02
Channel X	- Input	20000	-19988.8	-0.06
Channel Y	+ Input	200000	199999.9	0.00
Channel Y	+ Input	20000	19999.3	0.00
Channel Y	- Input	20000	-19993.8	-0.03
Channel Z	+ Input	200000	199999.6	0.00
Channel Z	+ Input	20000	20005.6	0.03
Channel Z	- Input	20000	-19995.4	-0.02

Low Range		Input (μV)	Reading (μV)	Error (%)
Channel X	+ Input	2000	1999.96	0.00
Channel X	+ Input	200	200.00	0.00
Channel X	- Input	200	-200.34	0.17
Channel Y	+ Input	2000	2000.03	0.00
Channel Y	+ Input	200	199.39	-0.31
Channel Y	- Input	200	-200.81	0.41
Channel Z	+ Input	2000	2000.07	0.00
Channel Z	+ Input	200	199.29	-0.36
Channel Z	- Input	200	-201.07	0.53

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Reading (μV)	Low Range Reading (μV)
Channel X	200	17.42	16.88
	- 200	-17.00	-17.10
Channel Y	200	14.86	14.26
	- 200	-15.53	-16.14
Channel Z	200	-8.63	-8.44
	- 200	7.15	7.51

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (µV)	Channel Y (µV)	Channel Z (µV)
Channel X	200	-	2.45	1.22
Channel Y	200	0.25	-	4.38
Channel Z	200	-1.29	0.37	-

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15983	16854
Channel Y	16210	16793
Channel Z	16173	16131

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec
Input 10MΩ

	Average (µV)	min. Offset (µV)	max. Offset (µV)	Std. Deviation (µV)
Channel X	0.46	-0.28	1.02	0.27
Channel Y	-1.06	-1.87	-0.38	0.25
Channel Z	-0.15	-1.01	0.88	0.36

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.2001	201.3
Channel Y	0.2001	199.6
Channel Z	0.2001	200.7

8. Low Battery Alarm Voltage

typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption

typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	–0.01	-8	-9

ADT CORP.

D5: 5GHz SYSTEM VALIDATION DIPOLE

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland

Client ADT (Auden)

CALIBRATION CERTIFICATE

Object(s)	D5GHzV2 - SN:1019
Calibration procedure(s)	QA CAL-05.v2 Calibration procedure for dipole validation kits
Calibration date:	February 23, 2004
Condition of the calibrated item	In Tolerance (according to the specific calibration document)

This calibration statement documents traceability of M&TE used in the calibration procedures and conformity of the procedures with the ISO/IEC 17025 international standard.

All calibrations have been conducted in the closed laboratory facility: environment temperature 22 +/- 2 degrees Celsius and humidity < 75%.

Calibration Equipment used (M&TE critical for calibration)

Model Type	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter EPM E4419B	GB41293874	2-Apr-03 (METAS, No 252-0250)	Apr-04
Power sensor E4412A	MY41495277	2-Apr-03 (METAS, No 252-0250)	Apr-04
Power sensor HP 8481A	MY41092317	18-Oct-02 (Agilent, No. 20021018)	Oct-04
RF generator R&S SMT06	100058	23-May-01 (SPEAG, in house check May-03)	In house check: May-05
Network Analyzer HP 8753E	US37390585	18-Oct-01 (SPEAG, in house check Nov-03)	In house check: Oct 05

	Name	Function	Signature
Calibrated by:	Katja Pokovic	Laboratory Director	
Approved by:	Fin Bomholt	R&D Director	

Date issued: February 26, 2004

This calibration certificate is issued as an intermediate solution until the accreditation process (based on ISO/IEC 17025 International Standard) for Calibration Laboratory of Schmid & Partner Engineering AG is completed.